

# Webinar on InAs/GaSb Mid-Wave Cascaded Superlattice Light Emitting Diodes

Presented by:



# Technical Group Leadership



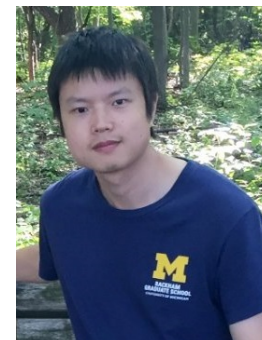
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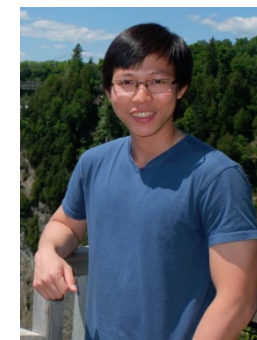
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## Laser Systems (PL)

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Information Acquisition, Processing & Display

Optical Interaction Science

#### Photonics and Opto-Electronics +

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Integrated Optics (PI)

**Laser Systems (PL)**

Optical Communications (PC)

Optics for Energy (PS)

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## Laser Systems (PL)

This group encompasses novel laser system development for a broad range of scientific, industrial, medical, remote sensing and other directed-energy applications. The group addresses technical issues concerning sources that cover the full spectral range, including: ultraviolet, visible, infrared, terahertz and microwave. Strong overlap with other technical groups that study and develop laser techniques and technologies brings together researchers and engineers to produce sources with unique performance, such as high-power, ultra-short pulses and high coherence.

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## Announcements

Join the Laser Systems Technical Group for their inaugural webinar on Tuesday, 31 May 2016, at 10:00 EDT.

In this webinar, Dr. John Prineas from the University of Iowa will present an overview of his research on InAs/GaSb mid-wave, cascaded superlattice light emitting diodes.

[Register for the Webinar Now>>](#)

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## Work in Optics

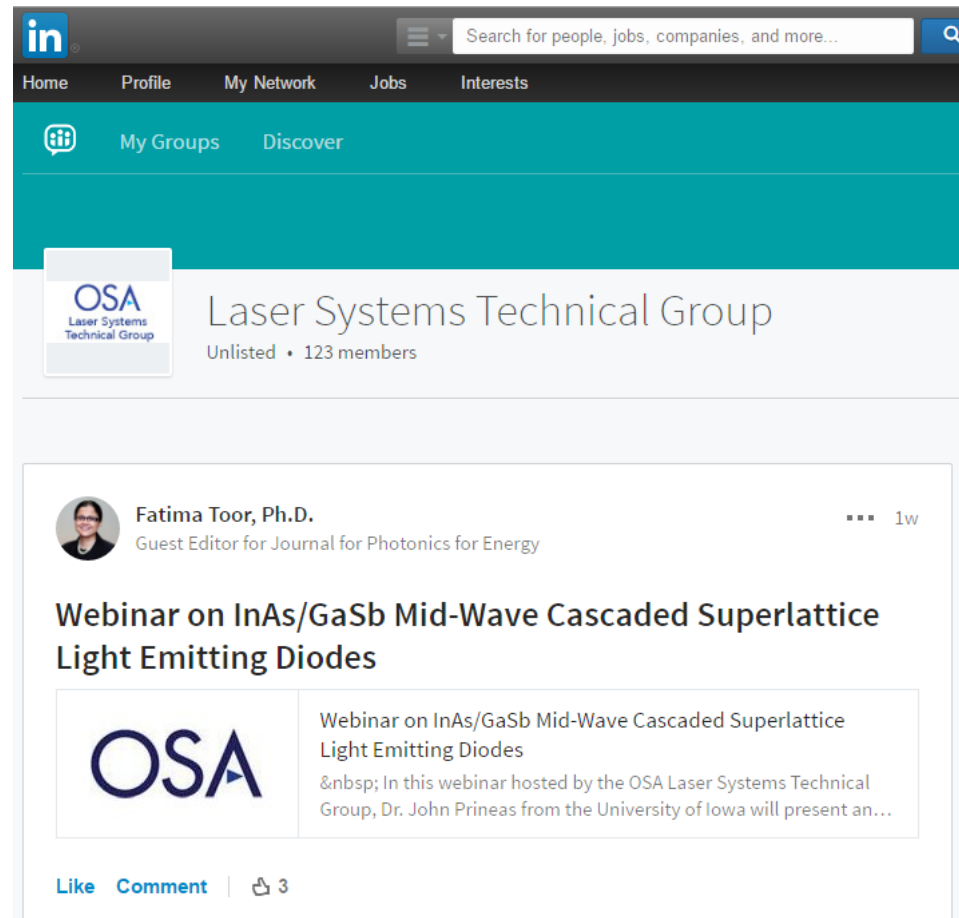
[FIELD SERVICE MANAGER | Checkpoint Technologies](#)

Thu, 05 May 2016 14:31:00 EST

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- LinkedIn site (global reach)
- Announce new activities
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**Welcome to Today's webinar!**

The poster for the webinar. It features a vertical strip on the left with a colorful, abstract, wavy pattern in shades of blue, green, and yellow. The main text is on the right, set against a light gray background with a diagonal blue line. The text reads: "WEBINAR ON INAs/GASb MID-WAVE CASCADED SUPERLATTICE LIGHT EMITTING DIODES" in dark blue, "31 May 2016 • 10:00 EDT" in red, and "Register today for this free OSA Technical Group webinar >>" in dark blue. The OSA Laser Systems Technical Group logo is in the bottom right corner.

WEBINAR ON INAs/GASb MID-WAVE CASCADED  
SUPERLATTICE LIGHT EMITTING DIODES

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John Prineas, Physics and Astronomy, University of Iowa, USA

<http://jprineas.lab.uiowa.edu/>

# InAs/GaSb Mid-Wave Cascaded Superlattice Light Emitting Diodes

John Prineas

Department of Physics and Astronomy, University of Iowa

May 31, 2016

Collaborator:

Thomas Boggess

Grad Students:

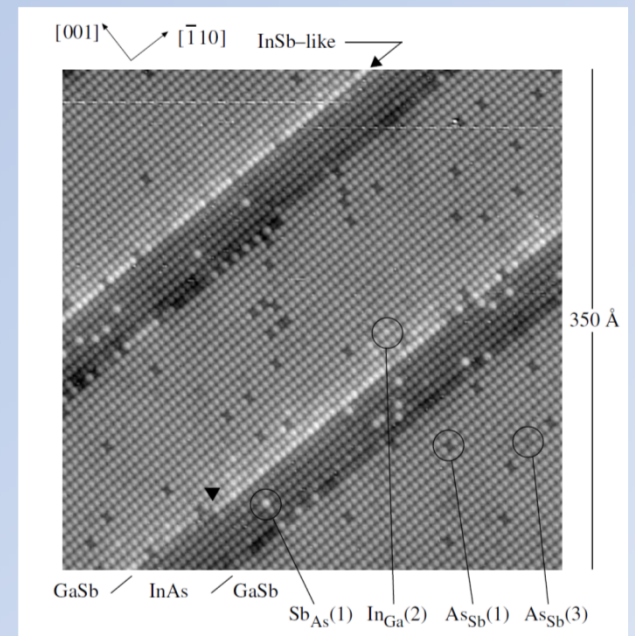
Yigit Aytak

Cassandra Bogh

Aaron Muhowski

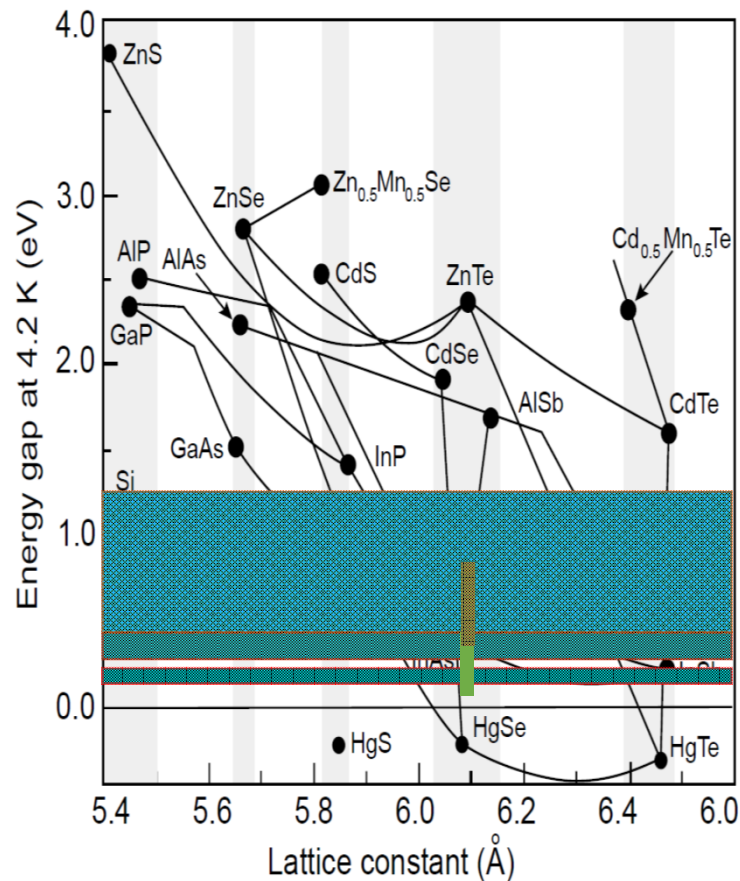
Sydney Provence

Russell Ricker



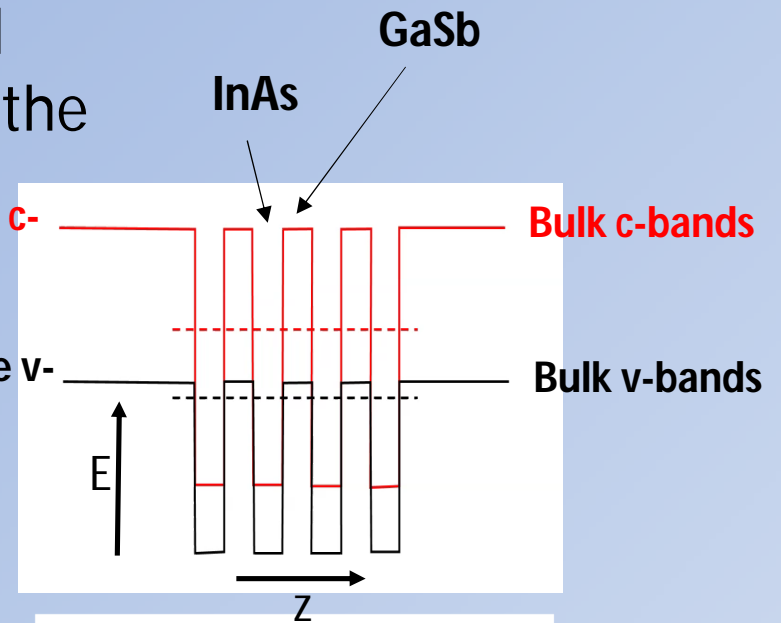
InAs/GaSb type II superlattices generated early interest due to their tunability over the mid- and long-wave infrared

- InAs/GaSb 3-30  $\mu\text{m}$
- GaInAsSb 1.7-4.9  $\mu\text{m}$



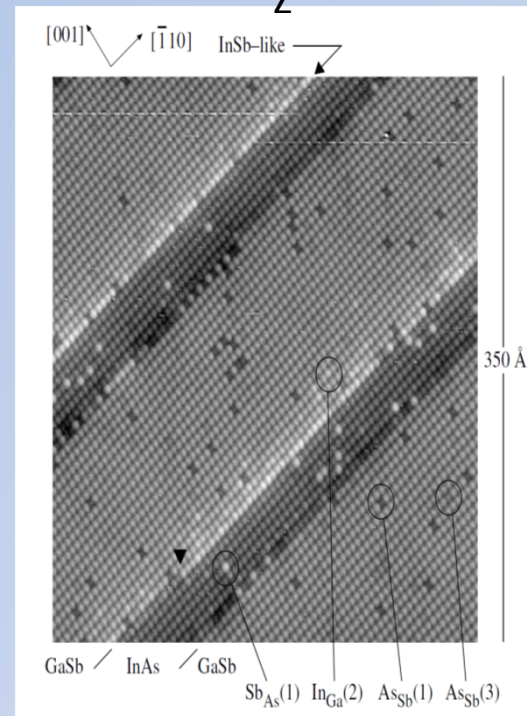
Superlattice c-band

Superlattice v-band



SWIR: 1-3  $\mu\text{m}$

MWIR: 3-5  $\mu\text{m}$   
LWIR: 8-12  $\mu\text{m}$



STM cross section of InAs/GaSb<sup>1</sup>

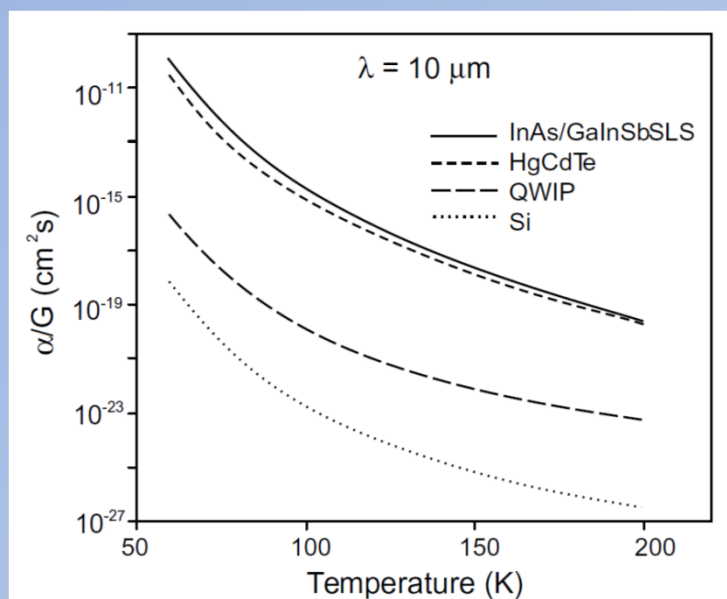
<sup>1</sup>Steinshneider et al, *Phys Rev Lett* **85**, 2953 (2000)

Type II superlattices have been shown in theory to be potentially better detector materials than  $\text{Hg}_x\text{Cd}_{1-x}\text{Te}$

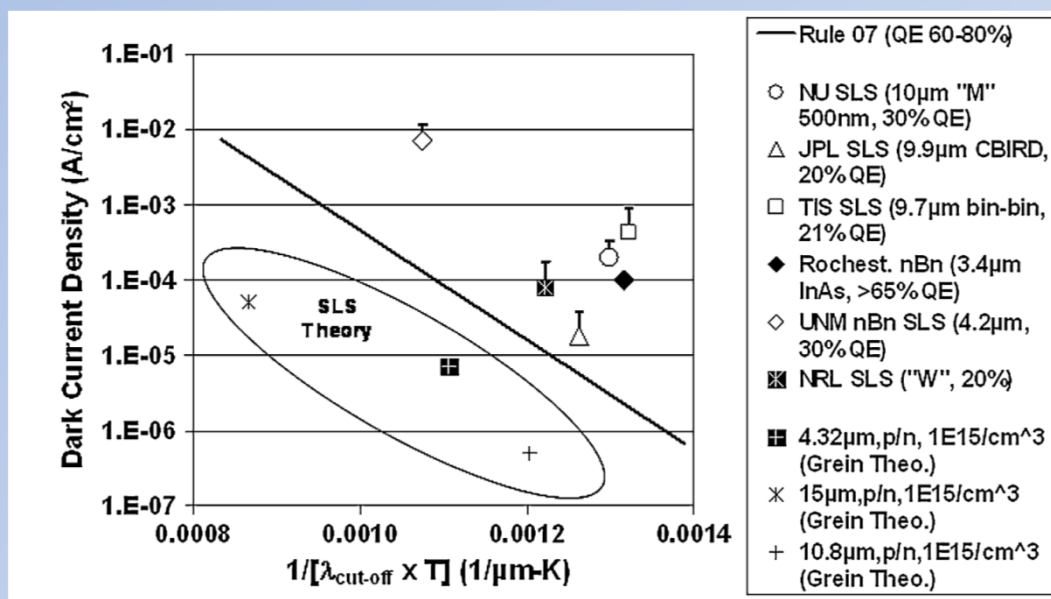
$$D^* \equiv \text{Specific detectivity} \propto \sqrt{\frac{\alpha}{G}} \propto \frac{R_i}{I_n}$$

$\alpha \equiv$  absorption coefficient  
 $G \equiv$  carrier generation rate

$R_i \equiv$  current responsivity  
 $I_n \equiv$  dark current noise



A. Rogalski et al, *Infrared Phys Technol* **48**, 39 (2006)



W.E. Tennant, *J Electron Mater* **39**, 1030 (2010)

The carrier generation/recombination rate in a semiconductor is determined by total carrier lifetime

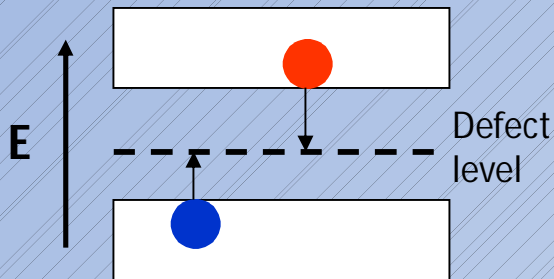
$$G \propto \frac{1}{\tau_{total}n}$$

$n$  is carrier density

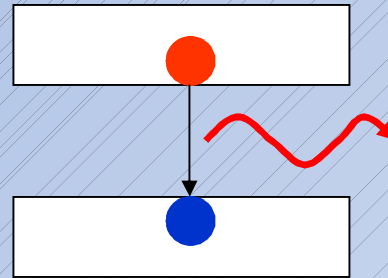
$\tau_{total}$  is total (minority) carrier lifetime

$$\frac{1}{\tau_{total}} = A_{SRH} + B_{rad}n + C_{Auger}n^2$$

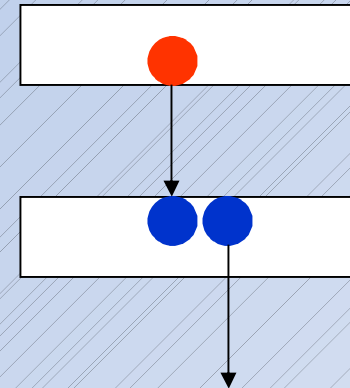
SRH rate =  $A_{SRH}$



Radiative rate =  $B_{rad}n$



Auger rate =  $C_{Auger}n^2$



The carrier generation/recombination rate in a semiconductor is determined by radiative and nonradiative (**Shockley-Read-Hall**, Auger) processes

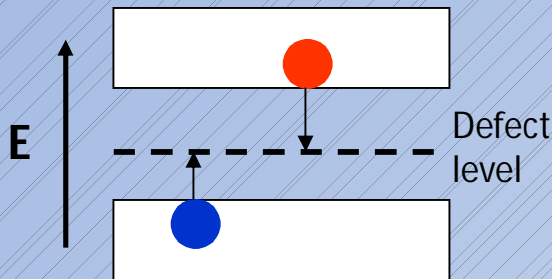
$$G \propto \frac{1}{\tau_{total} n}$$

$n$  is carrier density

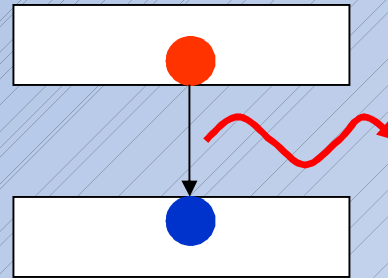
$\tau_{total}$  is total (minority) carrier lifetime

$$\frac{1}{\tau_{total}} = A_{SRH} + \underbrace{B_{rad} n}_{\text{Radiative recombination}} + C_{Auger} n^2$$

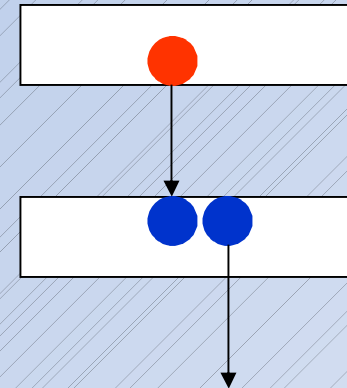
SRH rate =  $A_{SRH}$



Radiative rate =  $B_{rad} n$



Auger rate =  $C_{Auger} n^2$





The carrier generation/recombination rate in a semiconductor is determined by radiative and nonradiative (**Shockley-Read-Hall**, Auger) processes

$$G \propto \frac{1}{\tau_{total} n}$$

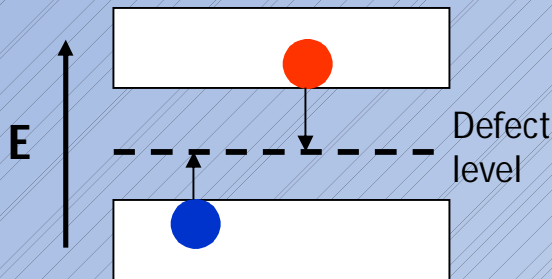
$n$  is carrier density

$\tau_{total}$  is total (minority) carrier lifetime

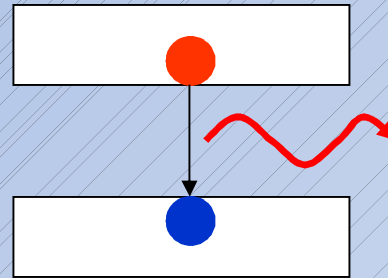
$$\frac{1}{\tau_{total}} = A_{SRH} + B_{rad}n + C_{Auger}n^2$$

Nonradiative recombination

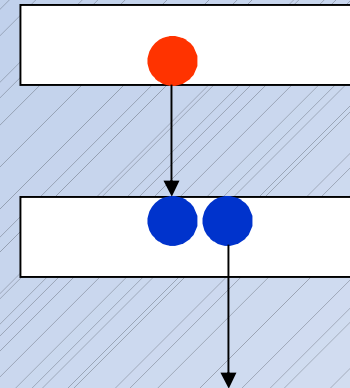
SRH rate =  $A_{SRH}$



Radiative rate =  $B_{rad}n$



Auger rate =  $C_{Auger}n^2$



The carrier generation/recombination rate in a semiconductor is determined by radiative and nonradiative (**Shockley-Read-Hall**, Auger) processes

$$G \propto \frac{1}{\tau_{total} n}$$

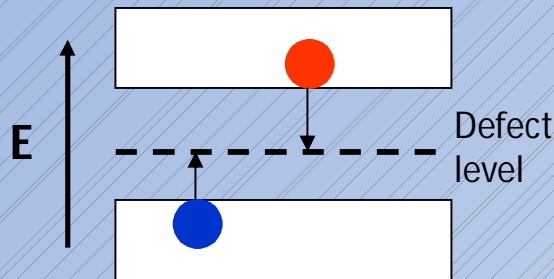
$n$  is carrier density

$\tau_{total}$  is total (minority) carrier lifetime

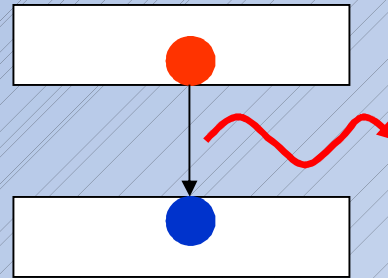
$$\frac{1}{\tau_{total}} = A_{SRH} + B_{rad}n + C_{Auger}n^2$$

- ❖ What makes InAs/GaSb superlattices so promising in theory is the possibility of using bandstructure engineering to suppress Auger recombination.

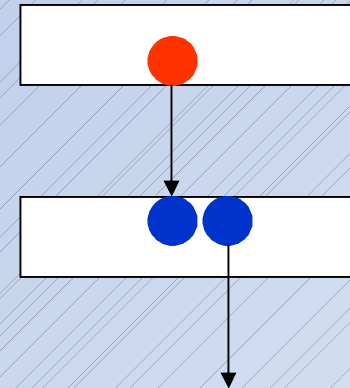
SRH rate =  $A_{SRH}$



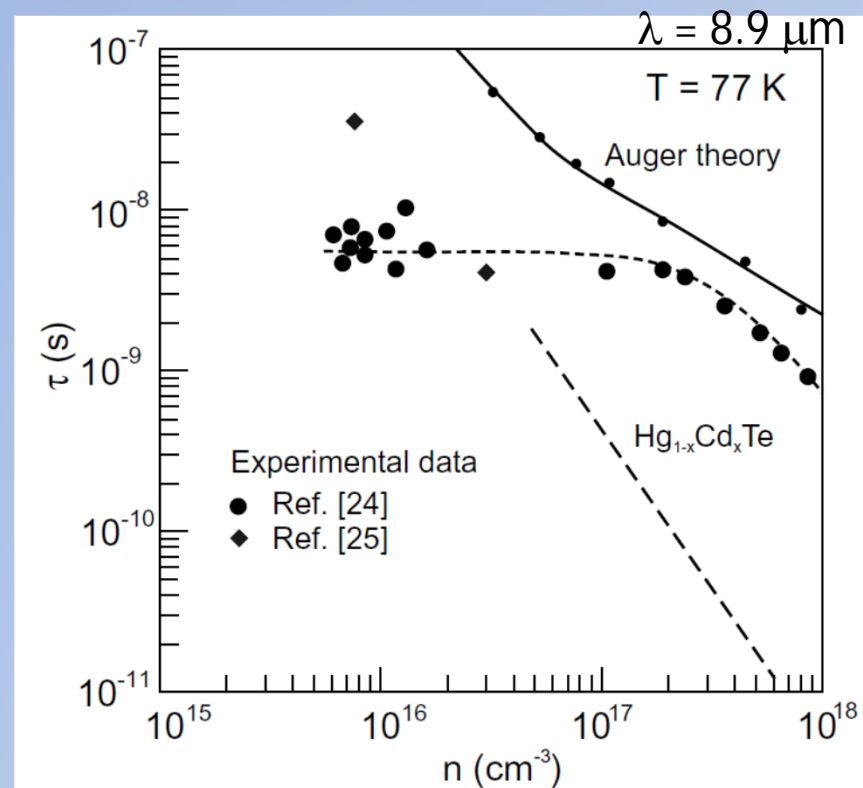
Radiative rate =  $B_{rad}n$



Auger rate =  $C_{Auger}n^2$

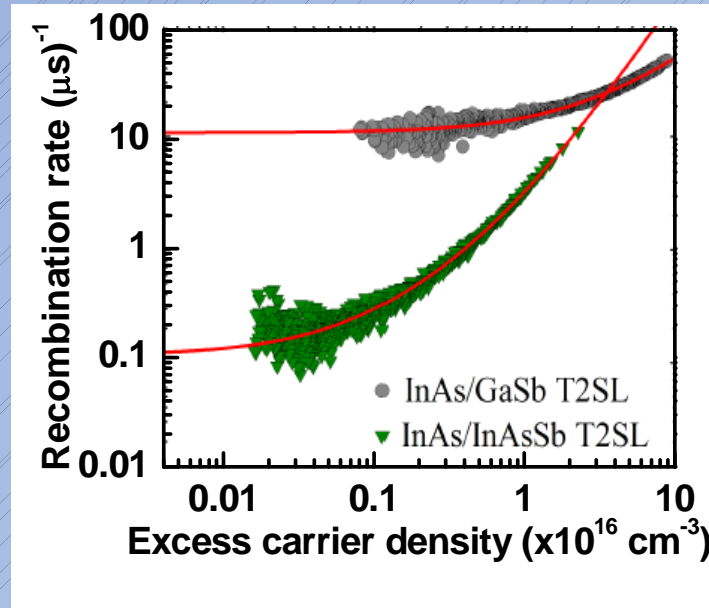


What holds InAs/GaSb superlattices back in practice is fast SRH (defect-assisted) nonradiative recombination; in contrast, SRH rate in  $\text{Hg}_x\text{Cd}_{1-x}\text{Te}$  is often treated as zero.



Youngdale et al *Appl Phys Lett* **78**, 7143 (1995)

Carrier lifetime studies in mid-wave ir InAs/GaSb superlattices at 77K confirm the small Auger coefficients but large SRH coefficients



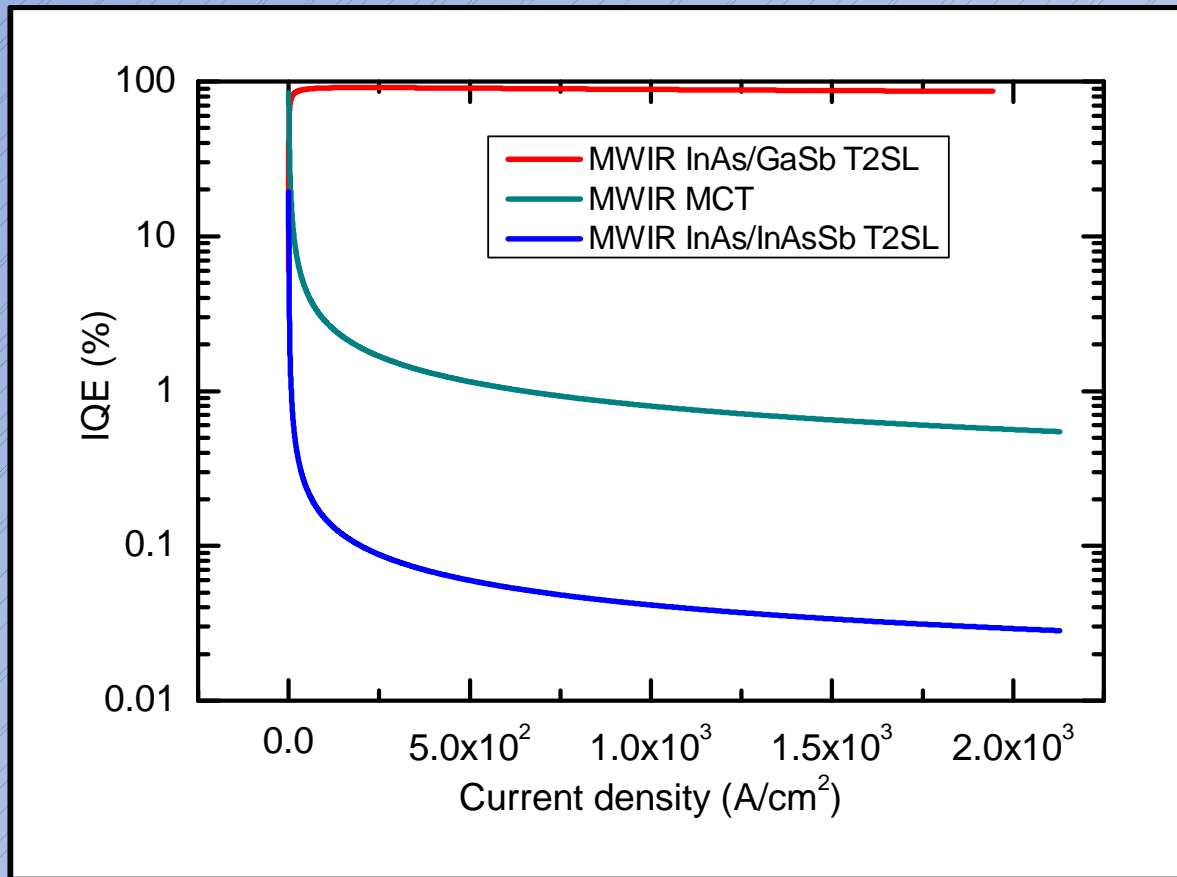
B.V. Olson et al, *Appl. Phys. Lett.* **101**, 092109 (2012).

$$\frac{1}{\tau_{total}} = A_{SRH} + B_{rad}n + C_{Auger}n^2$$

	$A_{SRH}^{-1}$ (ms)	$B_{rad}$ (cm <sup>3</sup> /s)	$C_{Auger}$ (cm <sup>6</sup> /s)
InAs/GaSb T2SL	0.092	$8 \times 10^{-10}$	$< 10^{-28}$
InAs/InAsSb T2SL	9.0	$1.7 \times 10^{-10}$	$6.0 \times 10^{-25}$
MWIR HgCdTe <sup>1</sup>	$\infty$	$2.2 \times 10^{-10}$	$4.0 \times 10^{-26}$

<sup>1</sup>M.A. Kinch, *J Electron Mater* **29**, 809 (2000)

For light emitting diodes, which operate at high carrier densities rather than low (detectors), radiative and Auger rates are much more important, and SRH unimportant



Internal Quantum Efficiency:

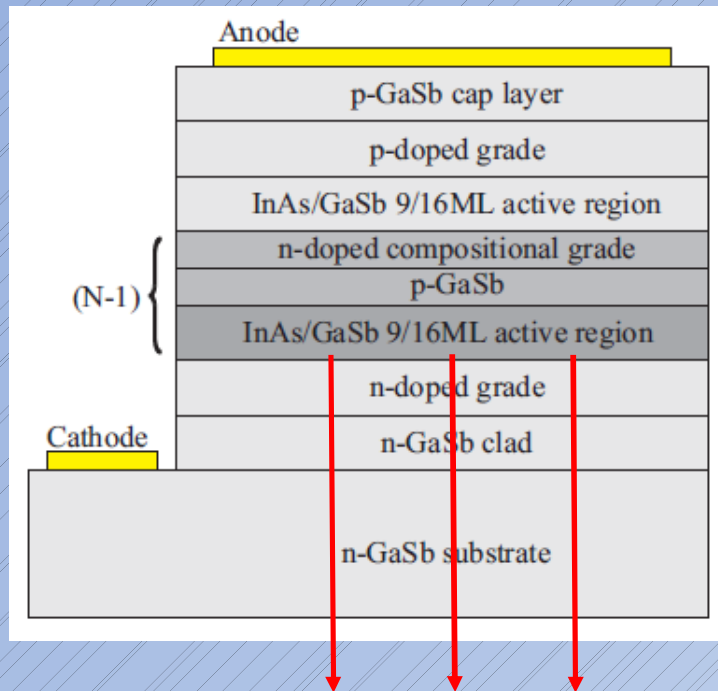
$$IQE \equiv \frac{\text{photons emitted}}{\text{injected carrier}}$$

$$IQE = \frac{B_{rad}n}{A_{SRH} + B_{rad}n + C_{Auger}n^2}$$

n is carrier density

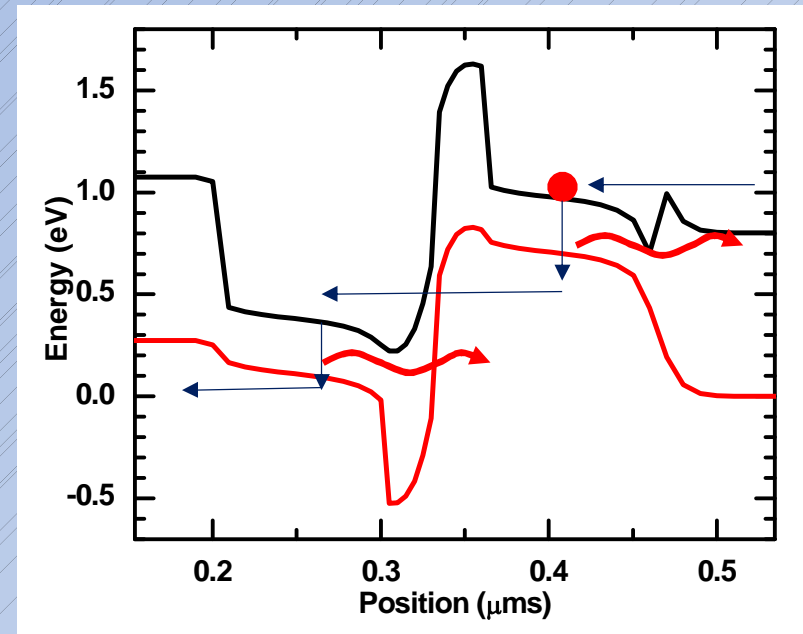
Due to the favorable Auger characteristics, we have used InAs/GaSb superlattices as the material of choice for high power light emitting diodes

Cascaded superlattice LED (SLEDs) Mesa Diode



Epitaxial structure fabricated into back-emitting LED

Diagram of a (biased) tunnel junction



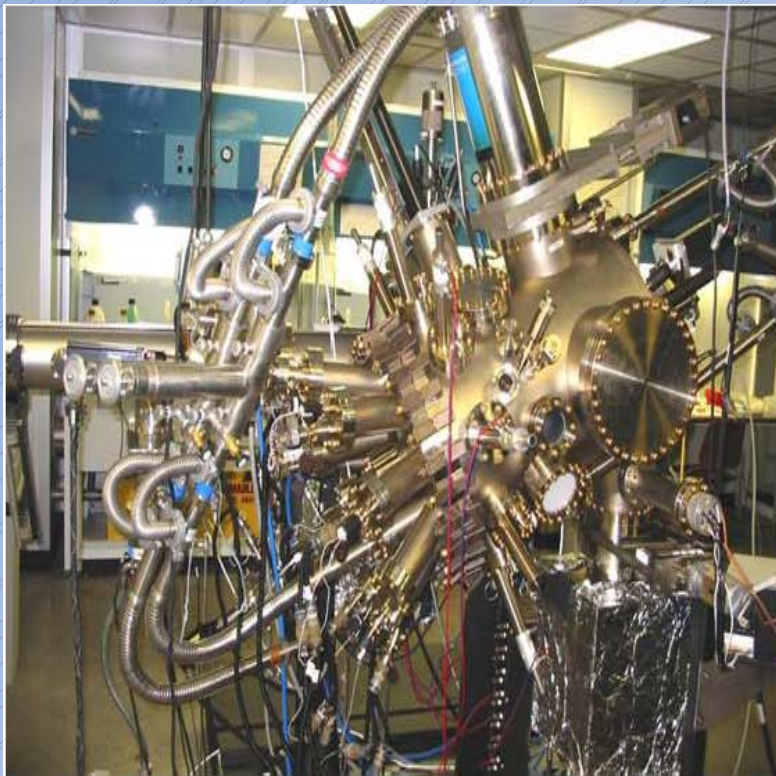
❖ N cascaded emission regions means each carrier can emit N photons instead of just one:

$$IQE_{N-stage} = N IQE_{1-stage}$$

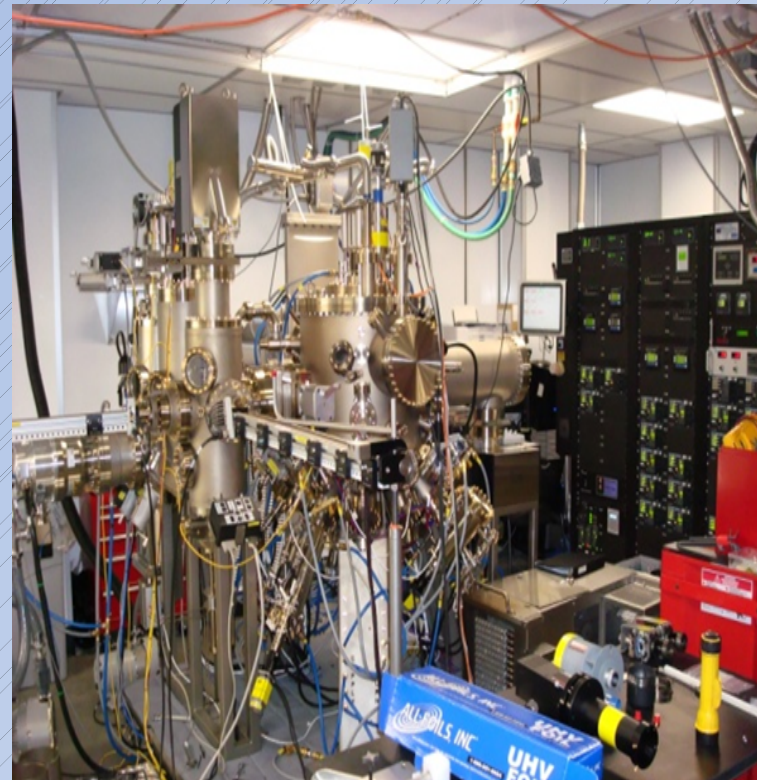


# MBE growth facility at the University of Iowa

**EPI930**

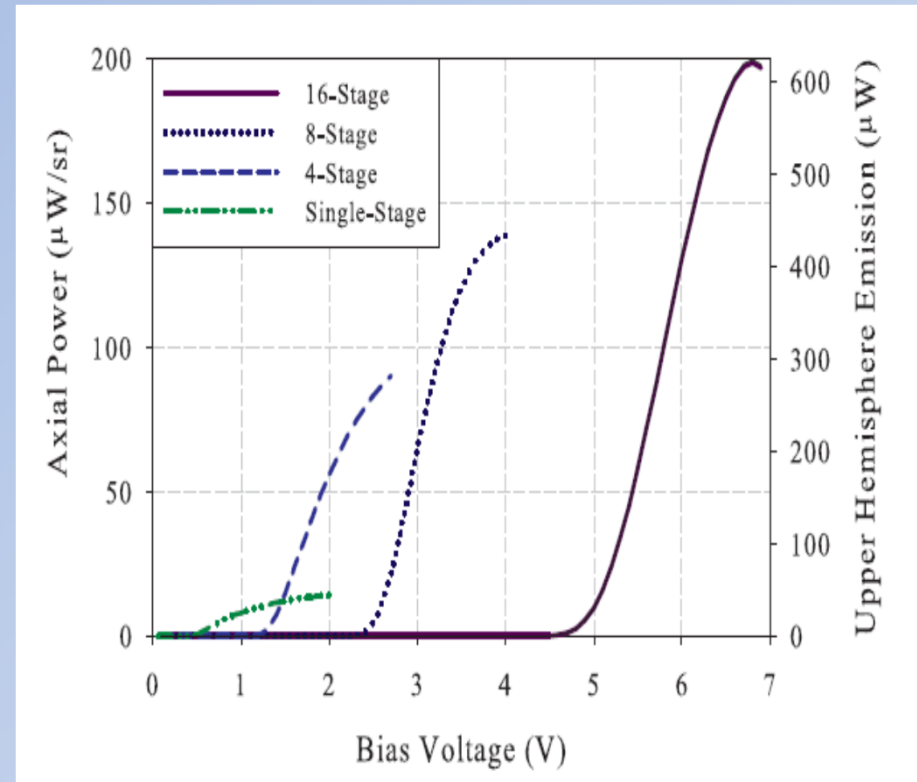
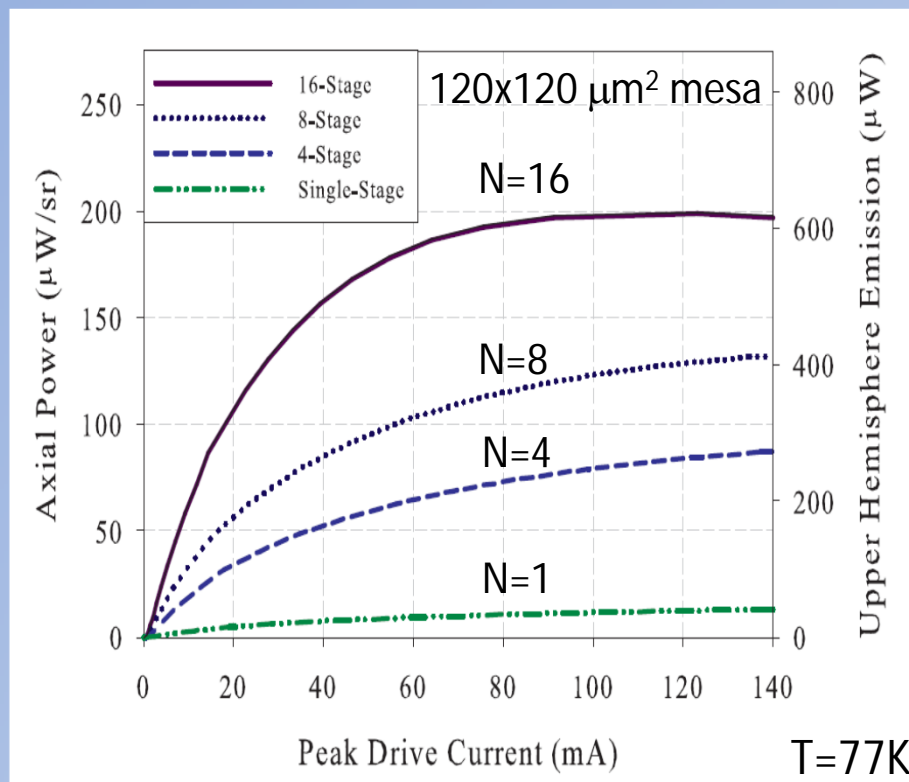


**GEN20**



The MWIR (and LWIR) cascaded InAs/GaSb superlattices mesa diodes exhibit high output power, and predicted scaling of output power with stages N

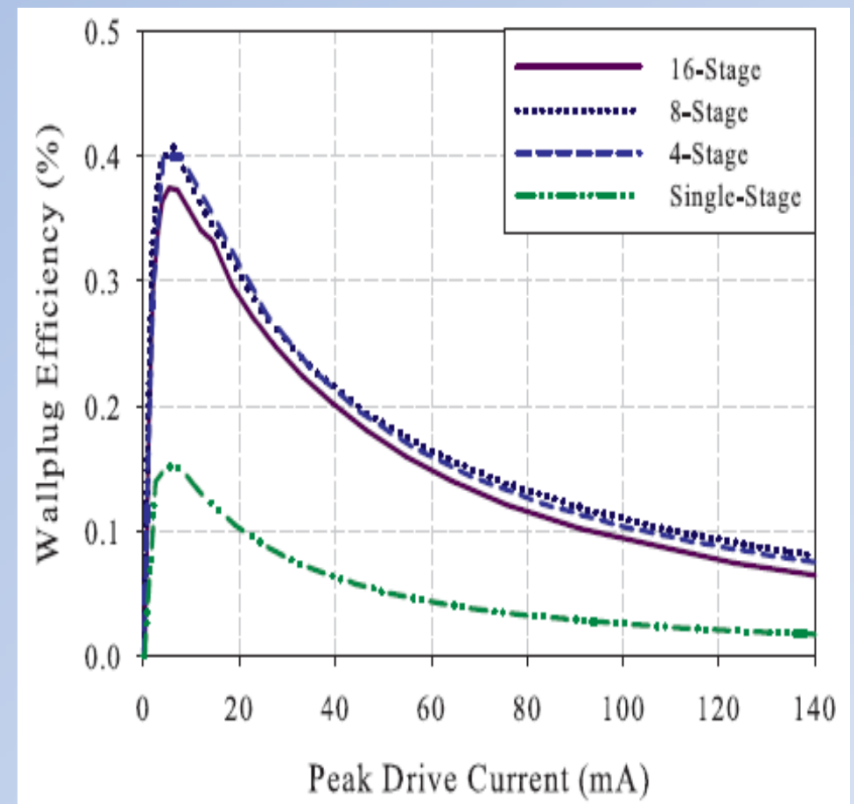
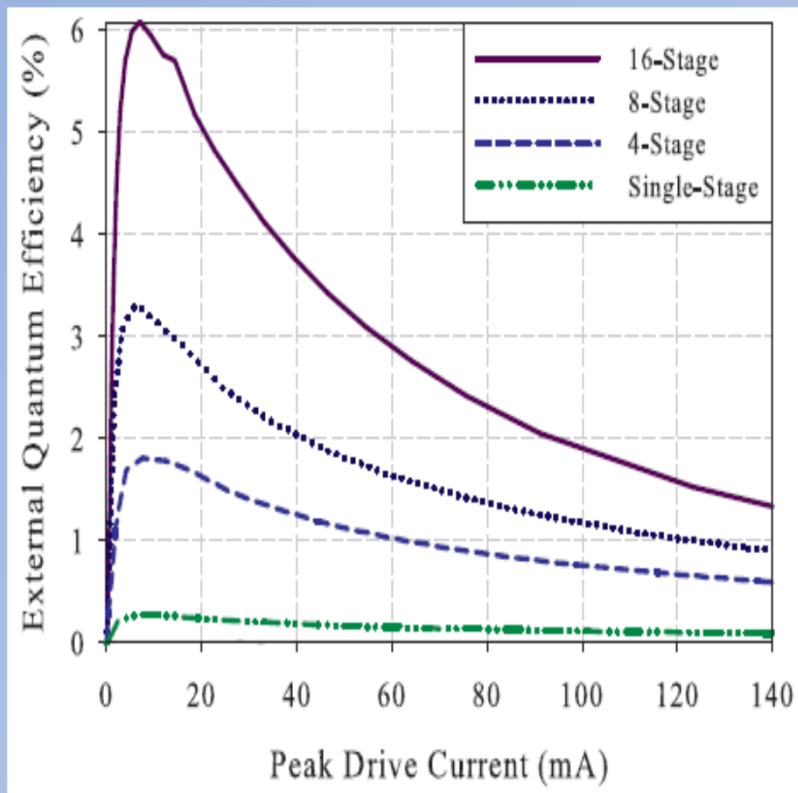
Cascaded SLEDs with variable number of stages:



Cascading helps external quantum efficiency, and wallplug efficiency by allowing operation at lower currents

*External quantum efficiency*  $\equiv \frac{\text{photons extracted}}{\text{electrons injected}}$

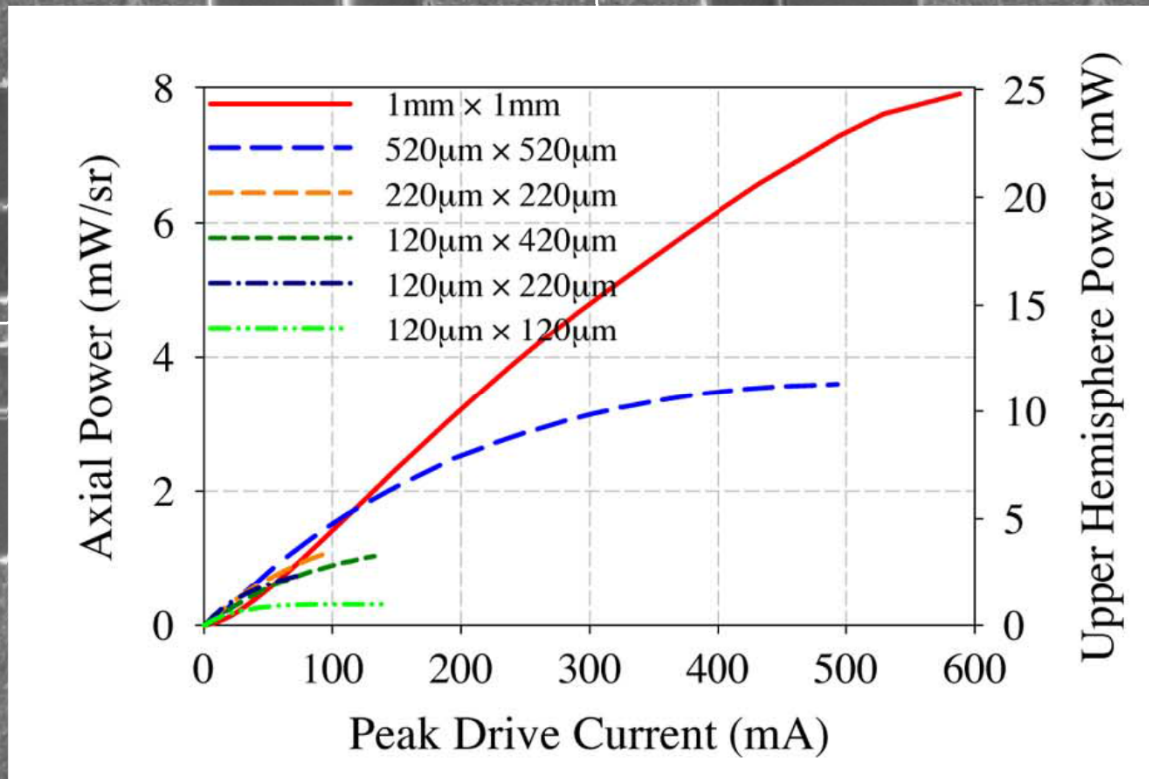
*Wallplug efficiency*  $\equiv \frac{\text{light power out}}{\text{electrical power in}}$





# Output power scaling with mesa size

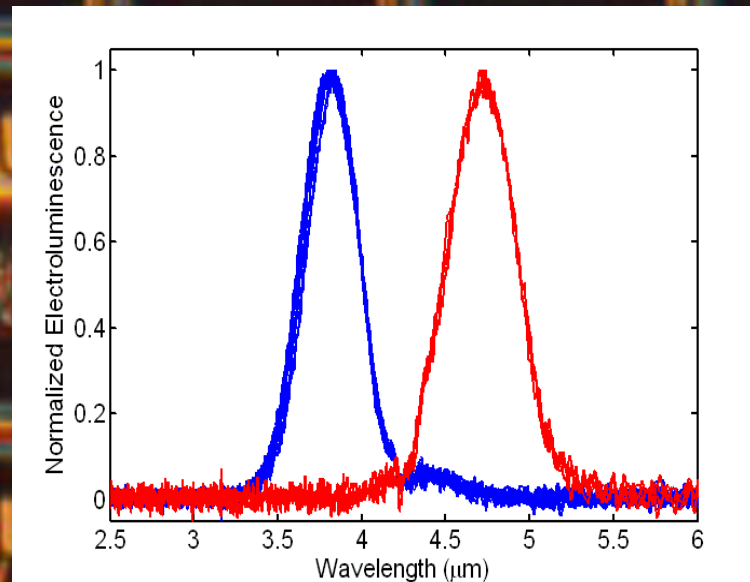
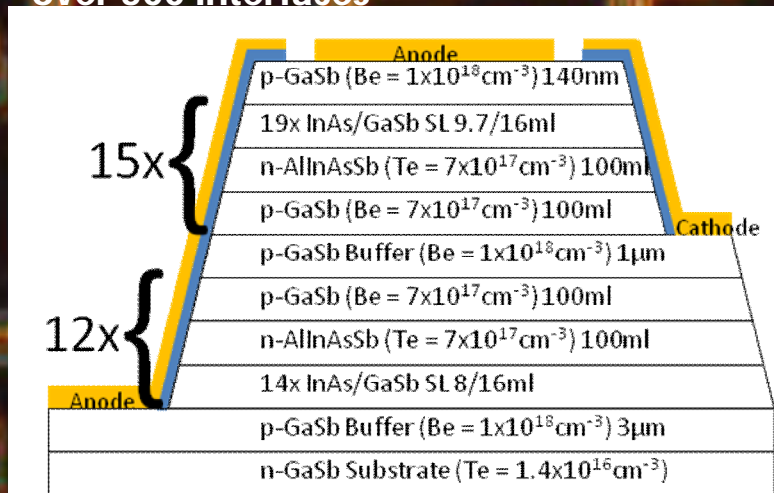
Sixteen stage SLEDs with variable mesa size (77K):



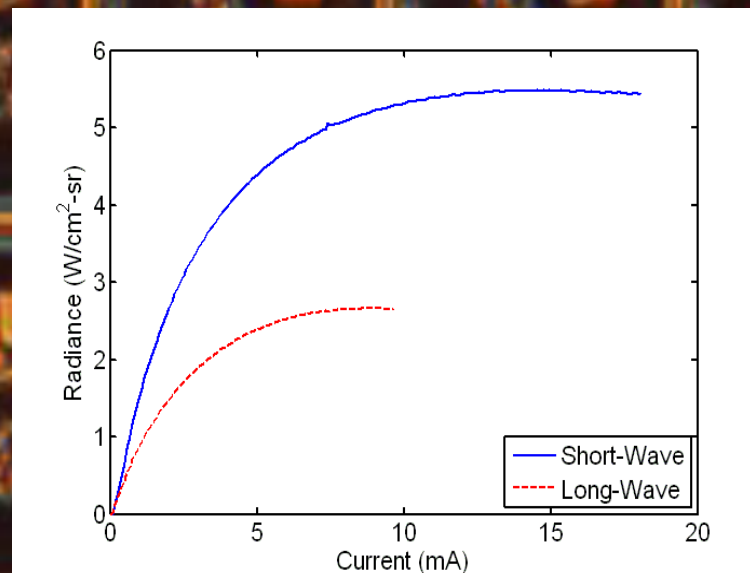
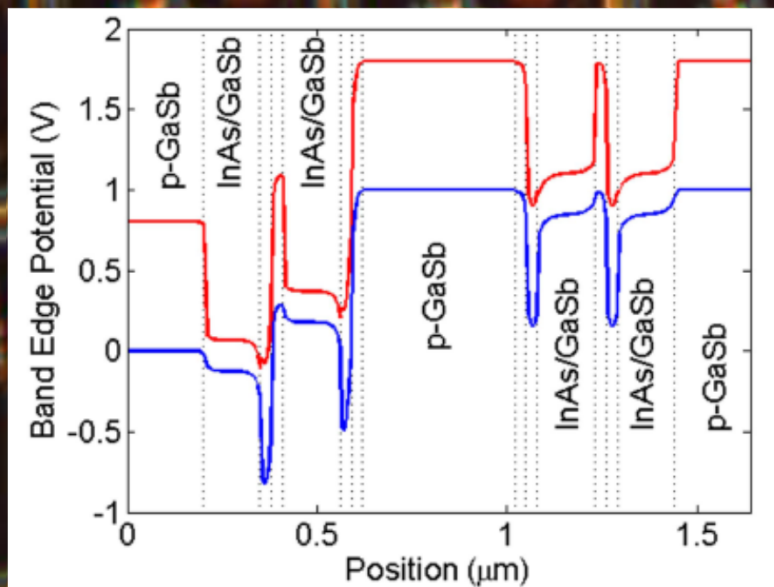
E. Koerperick et al, *IEEE J Quant Electron* **45**, 849 (2009)

# We have grown/fabricated InAs/GaSb MWIR two-color SLEDs independently operable at each color

28 stage device over 9  $\mu\text{m}$  thick with over 500 interfaces



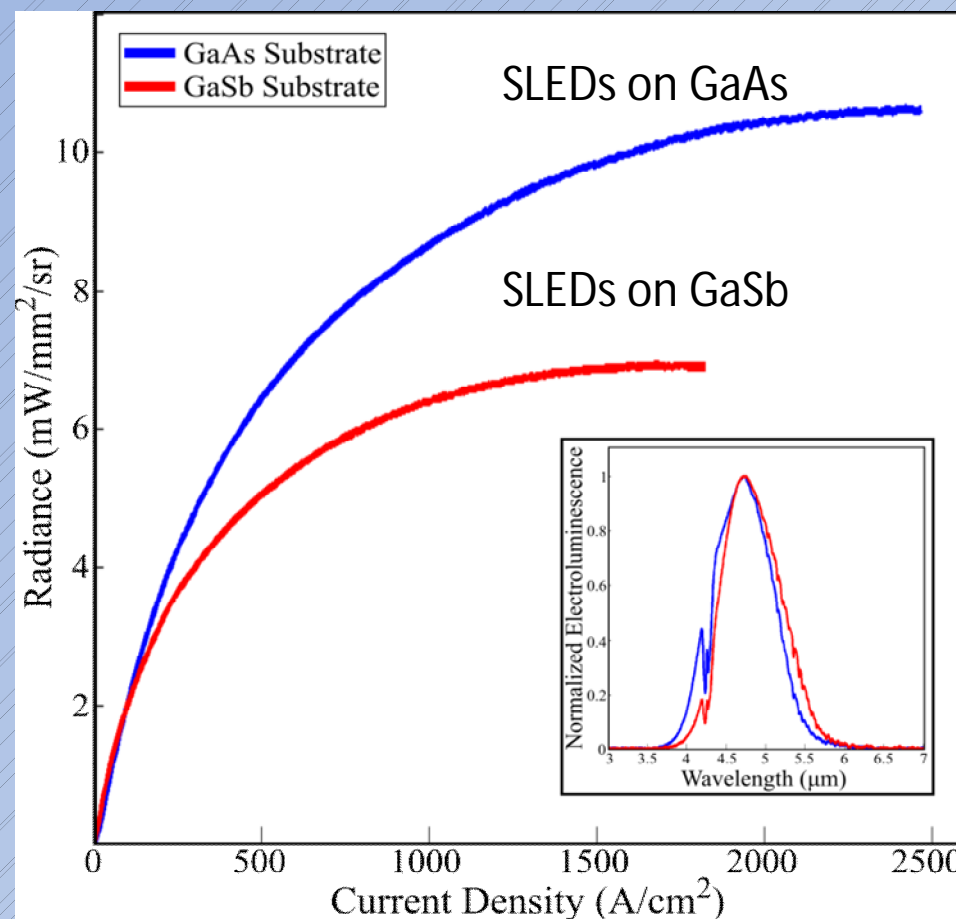
Operable at either color



Output-current at each color

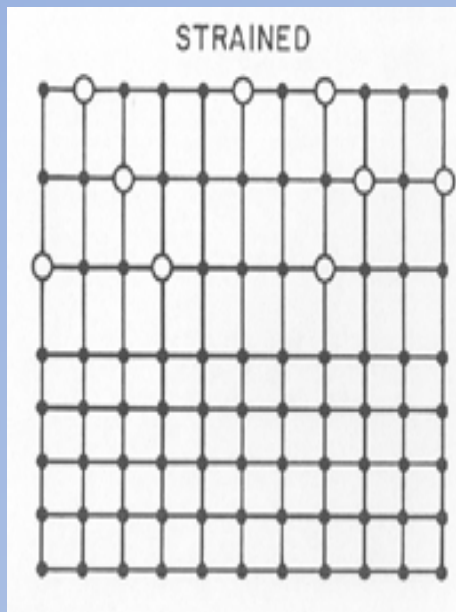
We have investigated growth of SLEDs on lattice-mismatched GaAs substrates. Surprisingly, more light came out than those grown on lattice-matched GaSb.

Light out versus current at 77K N=4

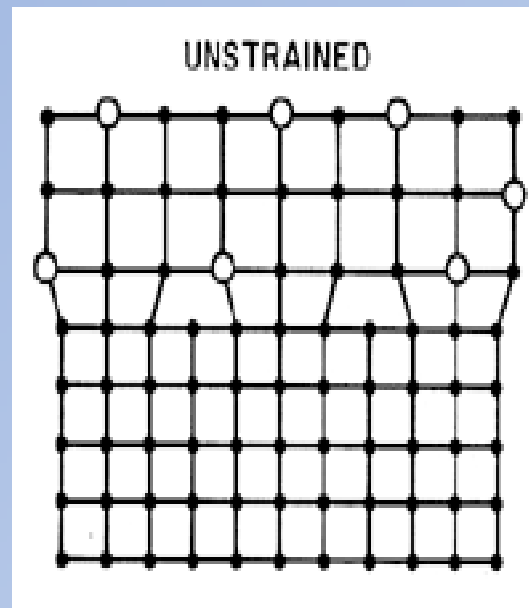




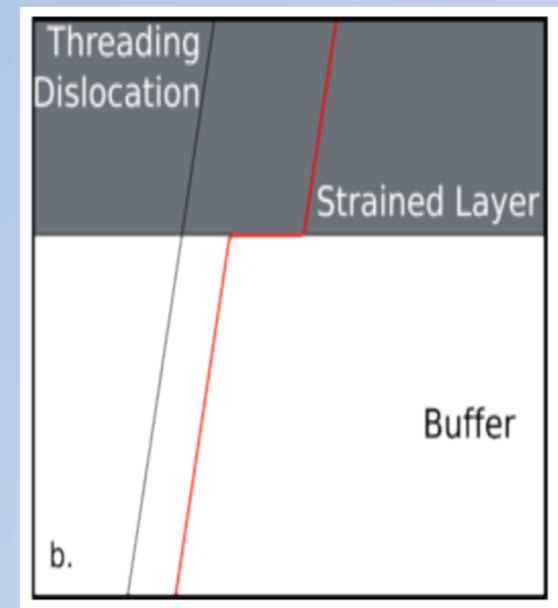
Why is it surprising that more light came out of material grown on lattice-mismatched GaAs (metamorphic growth) than lattice-matched GaSb (pseudomorphic growth)?



❖ Pseudomorphic growth: epilayer is fully strained to substrate

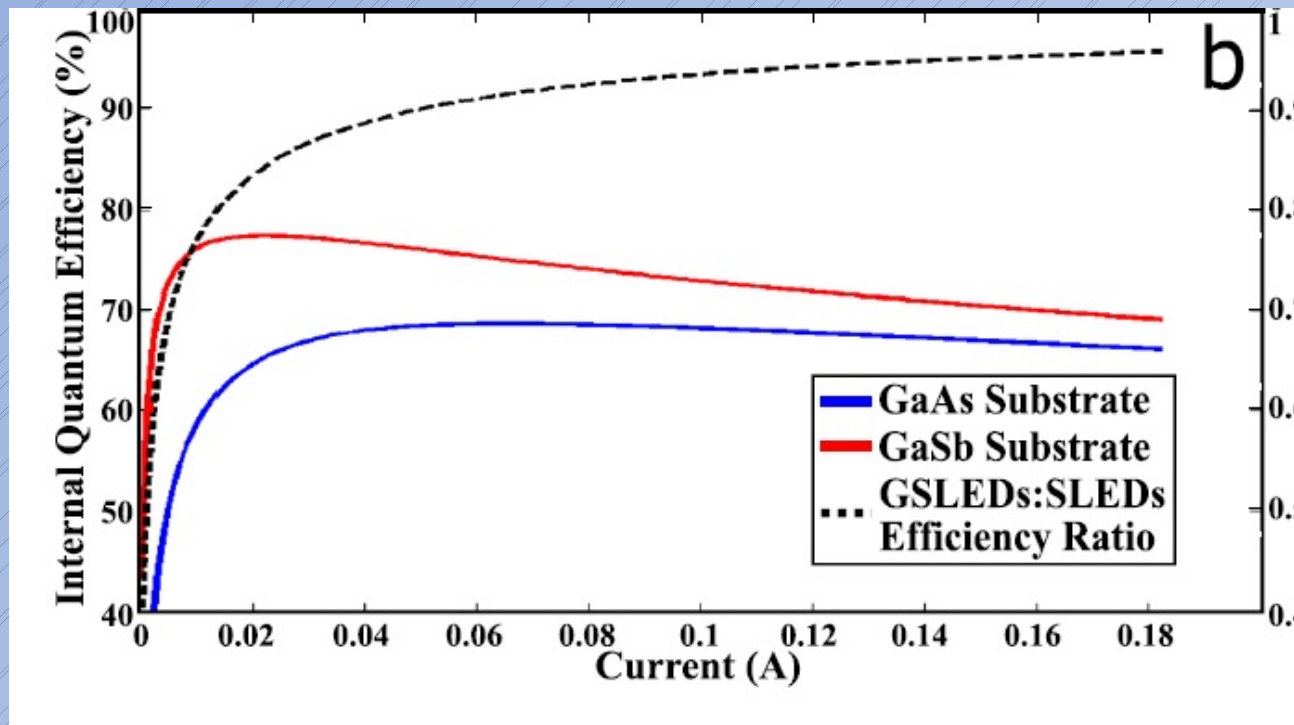


❖ Metamorphic growth: epilayer is fully relaxed through formation of misfit dislocations



❖ Misfit dislocations are not necessarily contained at interface, but can thread through epilayer creating defect states

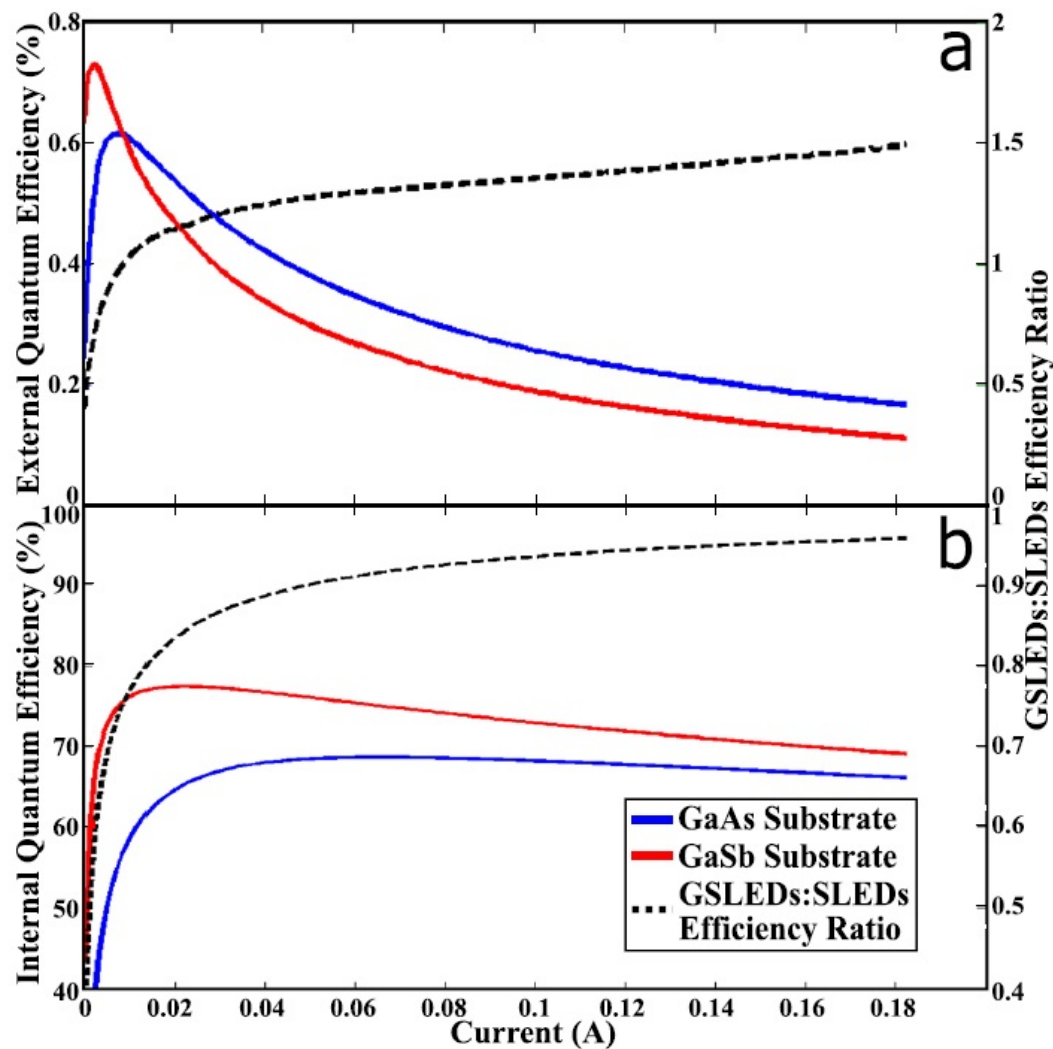
The misfit dislocations in SLEDs on GaAs increase the SRH nonradiative recombination rate, but SRH does not play an important role in the internal quantum efficiency



◆ Per stage internal quantum efficiency (photons produced / injected carrier) calculated from measured recombination coefficients is similar for SLEDs on GaAs and GaSb except at low current injection.

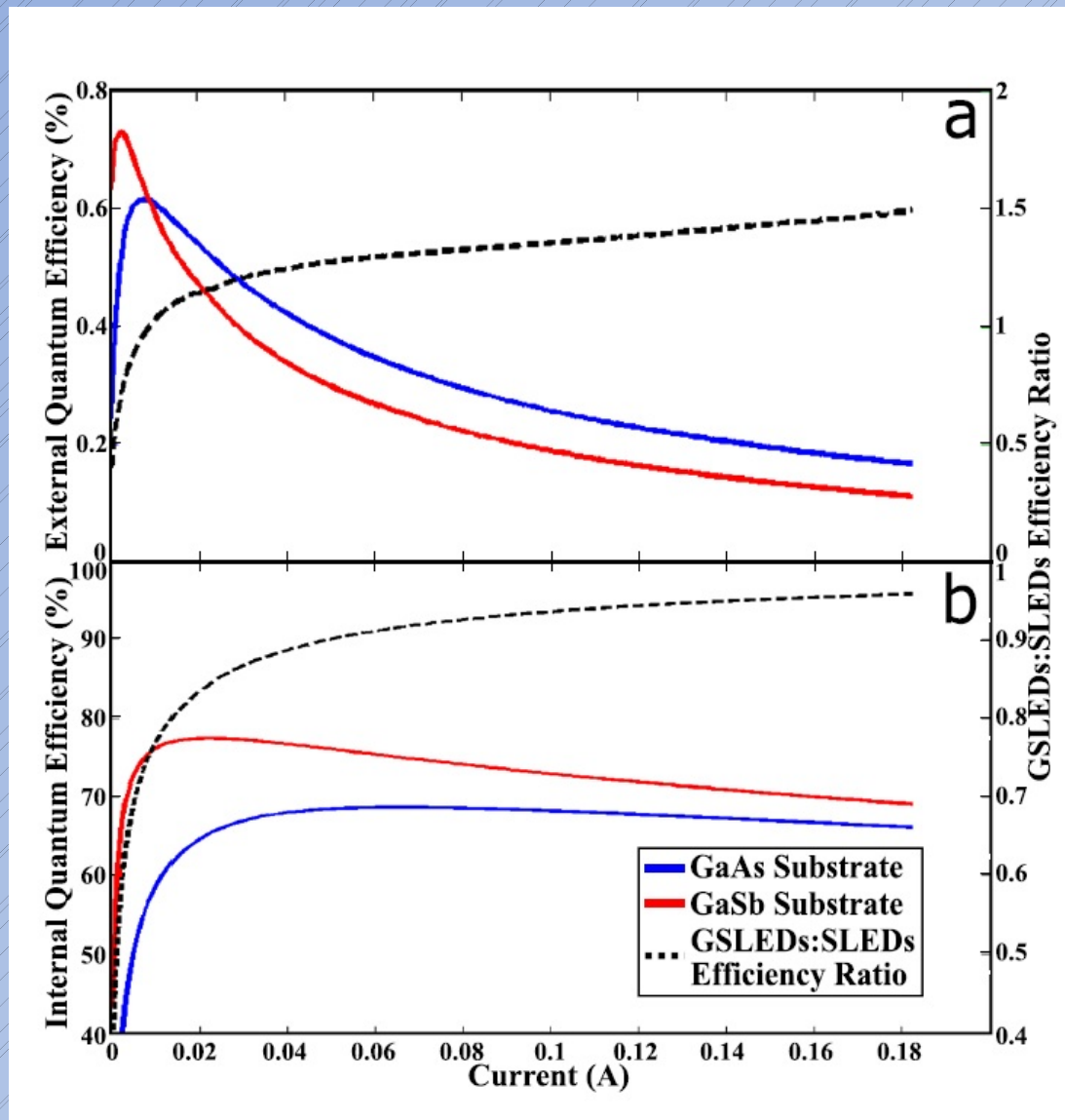
S. Provence et al, *J. Appl. Phys.* **118**, 123108 (2015).

The misfit dislocations in SLEDs on GaAs increase the SRH nonradiative recombination rate, but SRH does not play an important role in the internal quantum efficiency



- ❖ Measured external quantum efficiency (extracted photons / injected carrier) is slightly higher for SLEDs on GaAs.
- ❖ The difference in EQE is attributed mainly to higher transparency of GaAs substrate compared to GaSb.

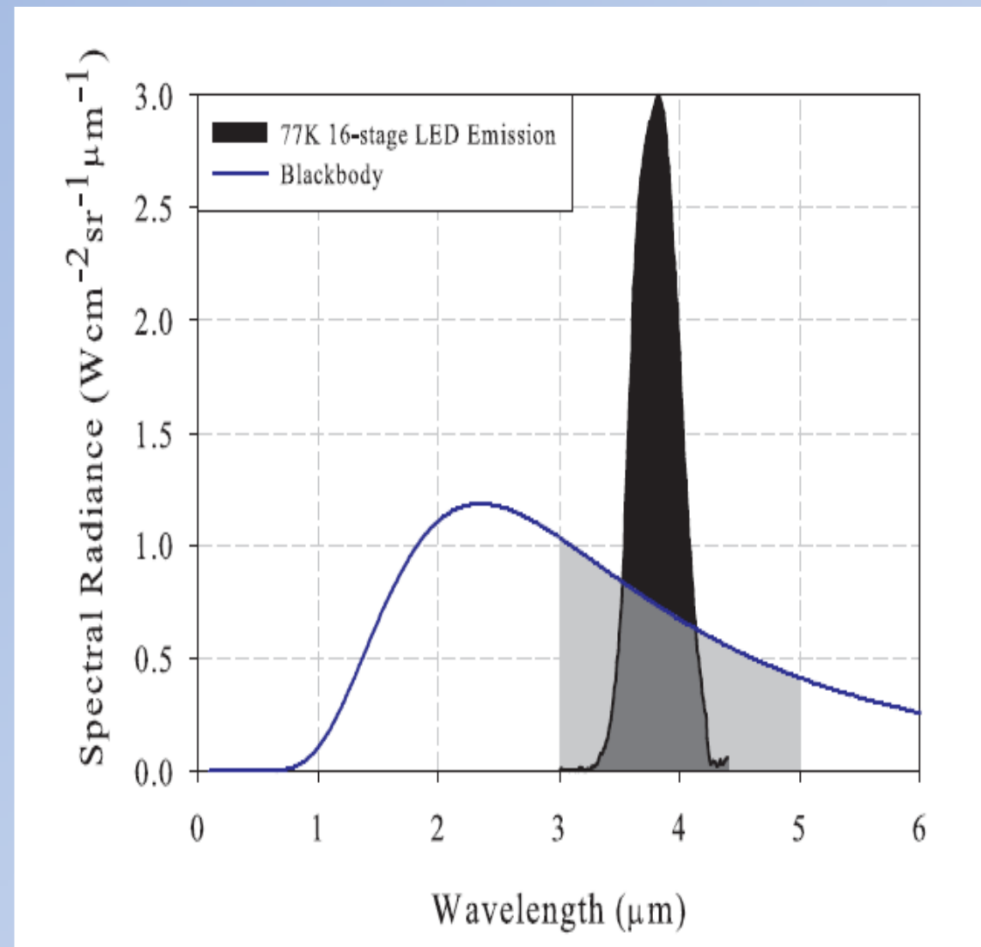
Also revealed by this comparison is the need for us to improve our extraction efficiency



- ❖ Light is hard to extract from the LEDs because the high index of refraction of the material tends to trap light through total internal reflection.
- ❖ LED output could be increased 10-100x by frustrating Snell's Law.
- ❖ Droop in EQE is attributed to sample heating, and power loss to high contact layer sheet resistance

# Thermal scene generation: generating scenes with apparent temperatures through high radiance LED arrays

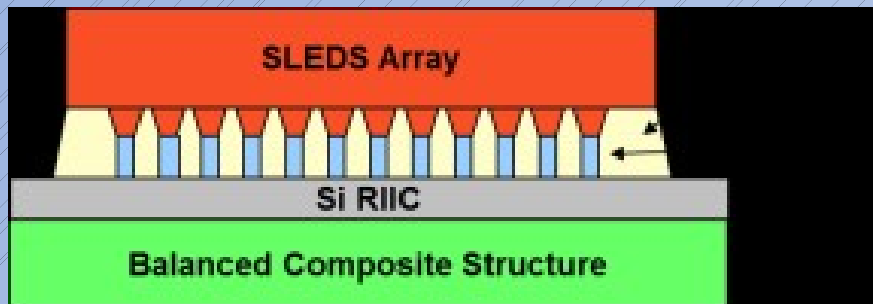
- Infrared LEDs emulate a blackbody in the sense of spectral radiance integrated over the mid-infrared – “power in a bucket” is the description sometimes used.
- Apparent temperatures of 2500 K state-of-the-art, equal to standard incandescent sources
- Apparent temperature of 6,000 K would equal the surface of the sun.



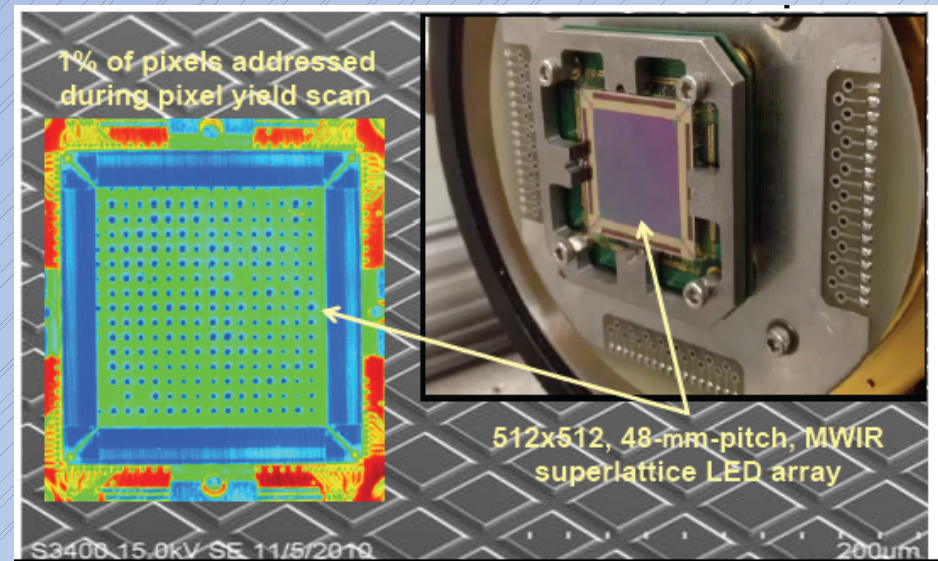
E. Koerperick et al, *IEEE J Quant Electron* **44**, 1242 (2008)

# Thermal scene projectors with 1500 K apparent temperature and 512x512 array demonstrated

Hybridization of SLEDs array and Si CMOS:



From J. Ejzak et al, submitted to *IEEE J. of Display Technology* (2015)



D.T. Norton et al, *IEEE J. of Quantum Electron.* **49**, 753 (2013)

- ❖ InAs/GaSb SLED used in LED array for thermal scene generation
- ❖ Pixel yield greater than 95%



## Conclusions

- ❖ Auger nonradiative recombination dominates over Shockley-Read Hall nonradiative recombination in LEDs. This makes InAs/GaSb a remarkable emitter compared to dominant detector materials such as HgCdTe or InAs/InAsSb.
- ❖ The unimportance of SRH in SLEDs opens the door to growth of SLEDs metamorphically on a variety of other advantageous substrates.
- ❖ The quantum efficiency of cascaded SLEDs scales with the number of stages  $N$ , while wallplug efficiency is technically independent of  $N$ .
- ❖ We have demonstrated SLEDs with two independently operable colors,  $512 \times 512$  SLEDs arrays, and SLEDs apparent temperatures of 2500K.
- ❖ Thermal scene generation is composed arrays of light emitters that generate an apparent temperature through radiance in wavelength range, or "power in a bucket."
- ❖ There are still potential major improvements in SLEDs output power